

# Silicon Carbide (SiC) **MOSFET** - EliteSiC, 53 mohm, 1700 V, M1, D2PAK-7L **NVBG050N170M1**

#### **Features**

- Typ.  $R_{DS(on)} = 53 \text{ m}\Omega$  @  $V_{GS} = 20 \text{ V}$
- Ultra Low Gate Charge (typ.  $Q_{G(tot)} = 107 \text{ nC}$ )
- Low Effective Output Capacitance (typ. C<sub>oss</sub> = 97 pF)
- 100% Avalanche Tested
- This Device is Halide Free and RoHS Compliant with Exemption 7a, Pb-Free 2LI (on second level interconnection)

#### **Typical Applications**

- Automotive On Board Charger
- Automotive DC-DC Converter for EV/HEV

#### MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			$V_{DSS}$	1700	V
Gate-to-Source Voltage	Gate-to-Source Voltage			-15/+25	V
Recommended Operation Values of Gate-to-Source Voltage		T <sub>C</sub> < 175 °C	$V_{GSop}$	-5/+20	٧
Continuous Drain Current (Note 2)	Steady State	T <sub>C</sub> = 25 °C	I <sub>D</sub>	50	Α
Power Dissipation (Note 2)			P <sub>D</sub>	385	W
Continuous Drain Current (Note 2)	Steady State	T <sub>C</sub> = 100 °C	I <sub>D</sub>	35	Α
Power Dissipation (Note 2)			P <sub>D</sub>	192	W
Pulsed Drain Current (Note 3)	T <sub>C</sub> = 25 °C t <sub>p</sub> = 100 μs		I <sub>DM</sub>	179	Α
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C
Continuous Source Current (Body Diode)			IS	87	Α
Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 22.8 A, L = 1 mH) (Note 4)			E <sub>AS</sub>	260	mJ
Maximum Lead Temperature for Soldering (1/8" from case for 10 s)			TL	270	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface mounted on a FR-4 board using1 in² pad of 2 oz copper.

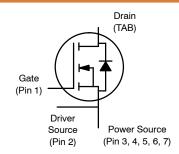
2. The entire application environment impacts the thermal resistance values shown,

- they are not constants and are only valid for the particular conditions noted.

1

- 3. Single pulse, limited by max junction temperature.
- 4.  $E_{AS}$  of 260 mJ is based on starting  $T_J = 25$  °C; L = 1 mH,  $I_{AS} = 22.8$  A,  $V_{DD} = 120 \text{ V}, V_{GS} = 18 \text{ V}.$

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
1700 V	76 mΩ @ 20 V	50 A



**N-CHANNEL MOSFET** 



D2PAK-7L CASE 418BJ

#### **MARKING DIAGRAM**

**BG050N** 170M1 **AYWWZZ** 

= Assembly Location

Υ = Year

WW = Work Week 77 Lot Traceability

BG050N170M1 = Specific Device Code

#### ORDERING INFORMATION

Device	Package	Shipping <sup>†</sup>
NVBG050N170M1	D2PAK-7L	800 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

## THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Max	Unit
Junction-to-Case – Steady State (Note 2)	$R_{\theta JC}$	0.39	°C/W
Junction-to-Ambient – Steady State (Notes 1, 2)	$R_{\theta JA}$	40	

# **ELECTRICAL CHARACTERISTICS** (T<sub>.I</sub> = 25 °C unless otherwise specified)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-to-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$	1700			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V <sub>(BR)DSS</sub> /T <sub>J</sub>	I <sub>D</sub> = 1 mA, referenced to 25 °C		0.5		V/°C
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	$V_{GS} = 0 \text{ V}, V_{DS} = 1700 \text{ V},$ $T_{J} = 25 \text{ °C}$			100	μΑ
		V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 1700 V, T <sub>J</sub> = 175 °C (Note 6)			1	mA
Gate-to-Source Leakage Current	I <sub>GSS</sub>	$V_{GS} = +25/-15 \text{ V}, V_{DS} = 0 \text{ V}$			±1	μΑ
ON CHARACTERISTICS (Note 3)						-
Gate Threshold Voltage	V <sub>GS(TH)</sub>	$V_{GS} = V_{DS}$ , $I_D = 10 \text{ mA}$	1.8	3.1	4.3	V
Recommended Gate Voltage	$V_{GOP}$		-5		+20	V
Drain-to-Source On Resistance	R <sub>DS(on)</sub>	$V_{GS}$ = 20 V, $I_D$ = 35 A, $T_J$ = 25 °C		53	76	mΩ
		V <sub>GS</sub> = 20 V, I <sub>D</sub> = 35 A, T <sub>J</sub> = 175 °C (Note 6)		107		
Forward Transconductance	9FS	V <sub>DS</sub> = 20 V, I <sub>D</sub> = 35 A (Note 6)		18		S
CHARGES, CAPACITANCES & GATE	RESISTANCE					
Input Capacitance	C <sub>ISS</sub>	V <sub>GS</sub> = 0 V, f = 1 MHz, V <sub>DS</sub> = 1000 V		2078		pF
Output Capacitance	C <sub>OSS</sub>	(Note 6)		97		]
Reverse Transfer Capacitance	C <sub>RSS</sub>			7.7		
Total Gate Charge	Q <sub>G(TOT)</sub>	$V_{GS} = -5/20 \text{ V}, V_{DS} = 1000 \text{ V},$		107		nC
Threshold Gate Charge	Q <sub>G(TH)</sub>	I <sub>D</sub> = 35 A (Note 6)		7.6		
Gate-to-Source Charge	$Q_{GS}$			31		
Gate-to-Drain Charge	$Q_{GD}$			25		
Gate-Resistance	$R_{G}$	f = 1 MHz		2.2		Ω
SWITCHING CHARACTERISTICS						
Turn-On Delay Time	t <sub>d(ON)</sub>	$V_{GS} = -5/20 \text{ V},$		14		ns
Rise Time	t <sub>r</sub>	$V_{DS} = 1200 \text{ V},$ $I_{D} = 35 \text{ A},$		22		
Turn-Off Delay Time	t <sub>d(OFF)</sub>	$R_G = 3.9 \Omega$ inductive load (Notes 5, 6)		44		
Fall Time	t <sub>f</sub>			13		]
Turn-On Switching Loss	E <sub>ON</sub>	]		803		μJ
Turn-Off Switching Loss	E <sub>OFF</sub>	]		198		1
Total Switching Loss	E <sub>tot</sub>	1		1001		1

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25 °C unless otherwise specified) (continued)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS (continued)						
Continuous Drain-Source Diode Forward Current	I <sub>SD</sub>	V <sub>GS</sub> = -5 V, T <sub>J</sub> = 25 °C			87	Α
Pulsed Drain-Source Diode Forward Current (Note 3)	I <sub>SDM</sub>				463	
Forward Diode Voltage	$V_{SD}$	$V_{GS} = -5 \text{ V}, I_{SD} = 35 \text{ A}, T_J = 25 ^{\circ}\text{C}$		4.3		V
Reverse Recovery Time	t <sub>RR</sub>	$V_{GS} = -5/20 \text{ V}, I_{SD} = 35 \text{ A},$		27		ns
Reverse Recovery Charge	$Q_{RR}$	dl <sub>S</sub> /dt = 1000 A/μs (Note 6)		233		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. E<sub>ON</sub>/E<sub>OFF</sub> result is with body diode.

6. Defined by design, not subject to production test.

#### **TYPICAL CHARACTERISTICS**

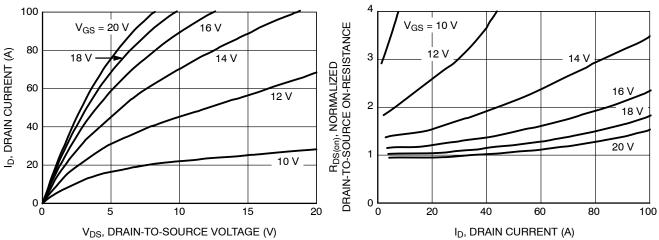


Figure 1. On-Region Characteristics

Figure 2. Normalized On-Resistance vs. Drain Current and Gate Voltage

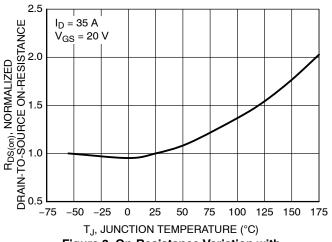


Figure 3. On-Resistance Variation with Temperature

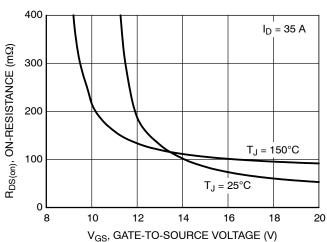
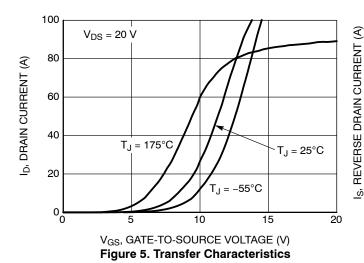
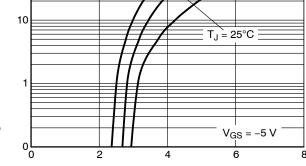


Figure 4. On-Resistance vs. Gate-to-Source Voltage

= -55°C





 $T_{.1} = 175^{\circ}C$ 

V<sub>SD</sub>, BODY DIODE FORWARD VOLTAGE (V)
Figure 6. Diode Forward Voltage vs. Current

100

#### **TYPICAL CHARACTERISTICS**

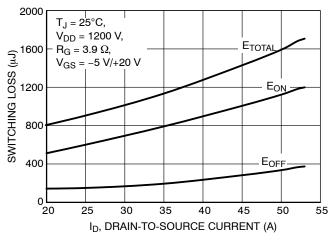


Figure 7. Switching Loss vs. Drain-to-Source Current (25 °C)

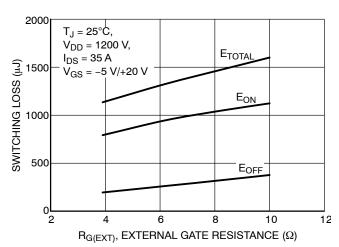


Figure 8. Switching Loss vs. External Gate Resistance

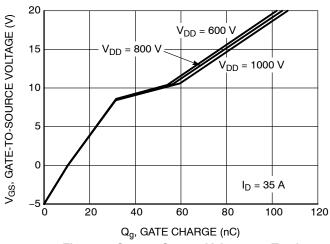


Figure 9. Gate-to-Source Voltage vs. Total Charge

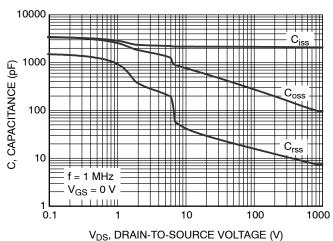


Figure 10. Capacitance vs. Drain-to-Source Voltage

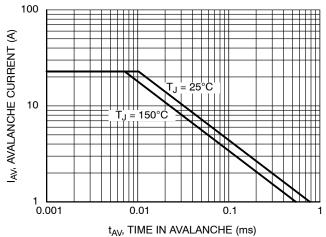


Figure 11. Unclamped Inductive Switching Capability

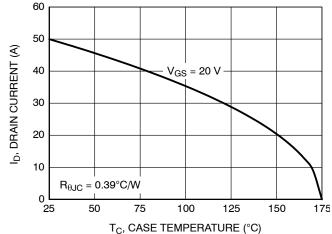


Figure 12. Maximum Continuous Drain
Current vs. Case Temperature

#### **TYPICAL CHARACTERISTICS**

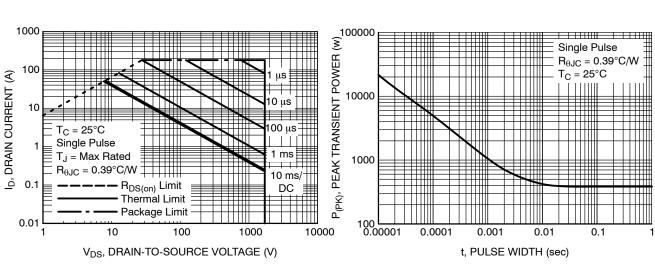


Figure 13. Maximum Rated Forward Biased Safe Operating Area

Figure 14. Single Pulse Maximum Power Dissipation

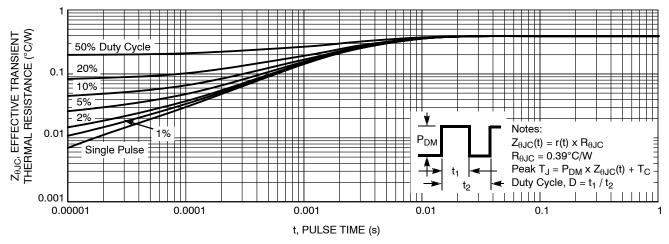
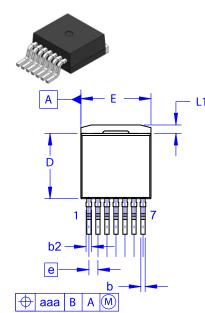


Figure 15. Transient Thermal Impedance



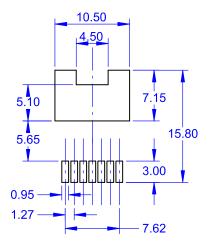


E1

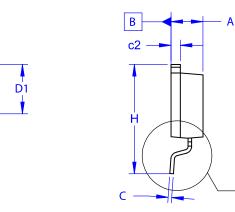
8

3.20 MIN

#### D<sup>2</sup>PAK7 (TO-263-7L HV) CASE 418BJ ISSUE B



LAND PATTERN RECOMMENDATION



#### **DATE 16 AUG 2019**

#### NOTES:

A. PACKAGE CONFORMS TO JEDEC TO-263 VARIATION CB EXCEPT WHERE NOTED. B. ALL DIMENSIONS ARE IN MILLIMETERS.

OUT OF JEDEC STANDARD VALUE.
D. DIMENSION AND TOLERANCE AS PER ASME
Y14.5-2009.

E. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.

54	MILLIMETERS				
DIM	MIN	NOM	MAX		
Α	4.30	4.50	4.70		
A1	0.00	0.10	0.20		
b2	0.60	0.70	0.80		
b	0.51	0.60	0.70		
С	0.40	0.50	0.60		
c2	1.20	1.30	1.40		
D	9.00	9.20	9.40		
D1	6.15	6.80	7.15		
Е	9.70	9.90	10.20		
E1	7.15	7.65	8.15		
е	~	1.27	~		
Н	15.10	15.40	15.70		
L	2.44	2.64	2.84		
L1	1.00	1.20	1.40		
L3	~	0.25	~		
aaa	~	~	0.25		

# GENERIC MARKING DIAGRAM\*



XXXX = Specific Device Code

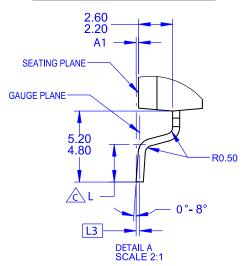
A = Assembly Location

Y = Year

WW = Work Week

G = Pb-Free Package

\*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.



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DESCRIPTION:	D <sup>2</sup> PAK7 (TO-263-7L HV)		PAGE 1 OF 1	

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